Personal Information Kenneth EZUKWOKE, Ph.D Data Scientist- GenAI, Datategy

 $\square +33(0)767962527$ **P** Paris, Île-de-France, France

ightharpoonup ifeanyi.ezukwoke@emse.fr ightharpoonup kennedyczar.github.io

¶ GoogleScholar R⁶ Researchgate ♠ github.com/kennedyCzar

in www.linkedin.com/in/kenneth-ezukwoke-4497b1155/



Professional Objective

I am currently a Data Scientist at Datategy working on papAI product development. This comes after obtaining a Ph.D in Applied Mathematics-GenAI and Industrial Engineering from École Nationale Supérieure des Mines de Saint-Étienne, working on Artificial Intelligence for Failure Analysis in Semiconductor Industry 4.0- an industrial collaboration with STMicroelectronics, Bosch, and Infineon AG under the FA4.0 EURIPIDES2-PENTA project. My research is focused on improving Generative Artificial intelligence via Bayesian Inference and Causal Large Language Models (LLMs), for decision-making during Failure Root Cause Analysis (FRCA). Advised by Professor Mireille Batton-Hubert, Professor Xavier Boucher (both from EMSE) and Pascal Gounet and Jerome Adrian (both Physical Failure Analyst Engineers, STMicroelectronics).

AWARDS









Top 10 of 100+ teams, AIRBUS Anomaly detection challenge,

Top 10 of 100+ teams across France in the **AIRBUS** anomaly detection challenge. Modeling using Variational Autoencoder and Desity based clustering.

T Summer Grant, ACM SIGCHI Summer Grant,

2019

2020

ACM SIGCHI Summer Grant Recipient ACM Summer Grant. Summer school held in Barcelona, Spain, focused on user modeling and personalization in urban computing.

T STUDENT RESEARCH GRANT, UCL QATAR,

2018-2019

Google Europe Udacity Scholarship recipient.

m FIRST CLASS DISTINCTION, VISTAS,

2017

 $Annual\ convocation\ ceremony\ Vels\ University.$

EDUCATION







Ph.D in Applied Math./Generative AI

École des Mines de Saint-Étienne (EMSE)

Saint-Étienne, France Oct. 2020 - Sept. 2023

- $\bullet\,$ PhD candidate in Applied Math. / A.I, Researching GenAI for Failure Analysis FA4.0 EU Project
- An EU collaboration between EMSE, STMicroelectronics and Infineon Technologies AG with the objective of developing an AI-based solution for fault analysis in Microelectronics manufacturing industries of the future.

M.Sc. Machine Learning and Data Mining [Bien (Good)] Université Jean Monnet (UJM) - Membre de l'Université de Lyon

Saint-Étienne, France Sept. 2019 - Aug. 2020

• Dual masters degree [MLDM] provides an original scientific position in Europe on problems related to machine learning, big data, pattern recognition, advance machine learning and advance AI.

B.Sc. Computer Application [Distinction]

Vels Institute of Science Technology and Advance Studies (VISTAS)

♥ Chennai, India June 2014 - May 2017

• Bachelors focusing on Statistics, Calculus, Algorithms and Data structure, software/Application development. Final Thesis on designing a CRM application for student monitoring.

Foundations of machine learning - MEHRYAR MOHRI

New York University (Courant Institute and Google Research online)

2018

• Regression, Convex optimization, kernel methods, Multi-class classification, Boosting, Reinforcement learning, Online learning, learning with finite and infinite hypothesis.

Machine learning for financial trading

Georgia Tech University

2017

• Deep learning algorithms, Machine Learning, Big data analysis and Stock prediction algorithms.







Publications





Manufacturing

nature portfolio



ACCEPTED











- K. Ezukwoke, H. Toubakh, A. Hoayek, M. Batton-Hubert, X. Boucher and P. Gounet, "Intelligent Fault Analysis Decision Flow in Semiconductor Industry 4.0 Using Natural Language Processing with Deep Clustering," 2021 IEEE 17th International Conference on Automation Science and Engineering (CASE), 2021, pp. 429-436, doi: 10.1109/CASE49439.2021.9551492.
- K. Ezukwoke, A. Hoayek, M. Batton-Hubert and X. Boucher, "GCVAE : Generalized-Controllable Variational AutoEncoder," arXiv, 2022, doi: 10.48550/ARXIV.2206.04225.
- Z. Wang, K. Ezukwoke, A. Hoayek, M. Batton-Hubert and X. Boucher, "NLP based on GCVAE for intelligent Fault Analysis in Semiconductor industry," *IEEE International Conference on Emerging Technologies and Factory Automation (ETFA-2022)*, doi: 10.1109/ETFA52439.2022.9921524.
- Ezukwoke, K., Hoayek, A., Batton-Hubert, M., Boucher, X., Gounet, P., and Adrian, J. (2022). Leveraging Pre-trained Models for Failure Analysis Triplets Generation. arXiv, doi: 10.48550/arXiv.2210.17497.
- A. Rammal, K. Ezukwoke, A. Hoayek and M. Batton-Hubert, "Root cause prediction for failures in semiconductor industry, a genetic algorithm—machine learning approach," Scientific Reports 13(1), 4934, doi: 10.1038/s41598-023-30769-8.
- K. Ezukwoke, A. Hoayek, M. Batton-Hubert and X. Boucher, "GCVAE: Generalized-Controllable Variational AutoEncoder," *BELIEF 2022. Poster*.
- K. Ezukwoke, A. Hoayek, M. Batton-Hubert and X. Boucher, "β- Variational AutoEncoder and Gaussian Mixture Model for Fault Analysis Decision Flow in Semiconductor Industry 4.0," *European Network for Business and Industriall Statistics (ENBIS-21)*. Poster.
- K. Ezukwoke, A. Hoayek, M. Batton-Hubert, X. Boucher and P. Gounet, "Big GCVAE: Decision-Making with Adaptive Transformer Model for Failure Root Cause Analysis in Semiconductor Industry *Journal of Intelligent Manufacturing (JIM)*.
- K. Ezukwoke, A. Hoayek, M. Batton-Hubert and X. Boucher, "GCVAE: Generalized-Controllable Variational AutoEncoder," *Journal of Machine Learning Research (JMLR)*.
- K. Ezukwoke, A. Hoayek, M. Batton-Hubert, X. Boucher and P. Gounet, "FAGPT: Leveraging Pretrained Models for Failure Analysis Triplet Generation." *Journal of Intelligent Manufacturing (JIM)*. **Accepted**.

Data Scientist- Generative AI

Datategy

 \bullet Generative artificial intelligence technology development for papAI and other intelligent product for Industry 4.0 automation.

Artificial Intelligence for Fault Analysis (FA4.0 EU Project)
STMicroelectronics

• Grenoble, France Oct. 2020 - Sept. 2023

Paris, France

Mar. 2024 - Present

 Designing an A.I solution based on probabilistic graphical model for decision-making during failure root cause analysis observed during production of microelectronics.

Machine Learning for Anomaly Detection on Complex Chemical Reactors

Feb. 2020 - Aug. 2020

Feb. 2020 - Aug. 2020

• Analysis of complex sensor time-series to detect anomalies during process monitoring of a pilot plant. Develop an a posteriori automated machine learning algorithm for early anomaly detection. Analysis of complex sensors, trends and potential anomalies.

DATA ANALYST/PYTHON DEVELOPER

Wölfel Engineering GmBH

• Wurzburg, Germany April 2018 - Aug. 2018

- Algorithm design and implementation for handling Wind turbine data from Offshore Windpark.
- Data analysis and visualization using white label technology for in-house usage.

DATA ANALYST/PYTHON DEVELOPER

Arun Cyber Technologies Ltd. (Startup Incubation Lab)

♥ Chennai, India Oct. 2016 - April 2017

• Data analysis for detecting cyber threat, intrusion and maintenance.

C# Software Developer

Vels Institute of Science, Technology Advanced Studies

• Chennai, India 2015 - 2016

- C# Software Developer for digital software department.
- Customer Relationship Management (CRM) software developer for Parent Student Monitor.
- University Database management system maintenance.
- SQL programming for database management.

SERVICE

Reviewer: WiML, IEEE CASE, EMNLP, AISTATS, ACL.

Affiliations

Organizations: CNRS UMR-6158 LIMOS, Blacks in AI, Masakhane.

VOLUNTEERING

The 10th International Conference on Learning Representations **♥** Virtual Apr. 25-29, 2022 ICLR. Sponsors: Meta, DeepMind, Google Research, Byte Dance, Microsoft



The 25th International Conference on Artificial Intelligence and Statistics V USA. [Virtual] AISTATS. Sponsors: G-Research, Google DeepMind, Facebook AI March 28-30, 2022



IEEE International Conference on Automation Science and Engineering **IEEE CASE.** Sponsors: IEEE, EMSE, INSA, IMT, LIMOS

• Lyon, France Aug. 23-27, 2021



Mentor on AI for Coral Reef Conservation in the Vamizi Island Sponsors: Sida, K4A, IDRC-CRDI Canada, UNESCO-IRCAI

Mozambique Oct. 2020 - 2021



The 24th International Conference on Artificial Intelligence and Statistics V USA. [Virtual] AISTATS. Sponsors: G-Research, Google DeepMind, Facebook AI

April 13-15, 2021

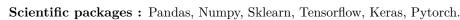
SKILLS

Operating systems: Linux, Windows.



Programming languages: Python, Bash, R, MATLAB.

Office softwares: LaTeX, Libre Office, Microsoft Office, Open Office.





Web applications: Django, Flask, Plotly Dash, Bokeh, Git.



Optimization : Algorithmic and convex optimization.



Languages: English, French.



Independent projects: Kernel methods, Cheese-coin (blockchain), Graph mining, Forecasting 1.0.

Invited talks

Plate-Forme Intelligence Artificielle (PFIA-22) Saint-Étienne, France

Presentation: Artificial intelligence for Fault Analysis in Semiconductor Industry Highlight: GCVAE with Transformers for structured data generation.

Teaching EXPERIENCE Big data clustering

École des Mines de Saint-Étienne (EMSE)

Saint-Étienne, France January, 2022



Introduction to Natural Language Processing (NLP)

École des Mines de Saint-Étienne (EMSE)

Saint-Étienne, France January, 2022

Deep Learning practical class

École des Mines de Saint-Étienne (EMSE)

♀ Saint-Étienne, France 2021